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# High Speed, Low Cost, Op Amp ADA4860-1

#### **FEATURES**

**High speed 800 MHz, −3 dB bandwidth 790 V/µs slew rate 8 ns settling time to 0.5% Wide supply range: 5 V to 12 V Low power: 6 mA 0.1 dB flatness: 125 MHz Differential gain: 0.02% Differential phase: 0.02° Low voltage offset: 3.5 mV (typ) High output current: 25 mA Power down** 

#### **APPLICATIONS**

**Consumer video Professional video Broadband video ADC buffers Active filters** 

#### **GENERAL DESCRIPTION**

The ADA4860-1 is a low cost, high speed, current feedback op amp that provides excellent overall performance. The 800 MHz, −3 dB bandwidth, and 790 V/µs slew rate make this amplifier well suited for many high speed applications. With its combination of low price, excellent differential gain (0.02%), differential phase (0.02°), and 0.1 dB flatness out to 125 MHz, this amplifier is ideal for both consumer and professional video applications.

The ADA4860-1 is designed to operate on supply voltages as low as +5 V and up to ±5 V using only 6 mA of supply current. To further reduce power consumption, the amplifier is equipped with a power-down feature that lowers the supply current to 0.25 mA.

The ADA4860-1 is available in a 6-lead SOT-23 package and is designed to work over the extended temperature range of −40°C to +105°C.

### **PIN CONFIGURATION**





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### **REVISION HISTORY**

4/06-Revision 0: Initial Version



### <span id="page-2-0"></span>**SPECIFICATIONS**

 $V_s = +5$  V (@ T<sub>A</sub> = 25°C, G = +2, R<sub>L</sub> = 150  $\Omega$  referred to midsupply, C<sub>L</sub> = 4 pF, unless otherwise noted). For G = +2, R<sub>F</sub> = R<sub>G</sub> = 499  $\Omega$  and for G = +1,  $R_F$  = 550  $\Omega$ .

#### **Table 1.**



 $V_S = \pm 5$  V (@ T<sub>A</sub> = 25°C, G = +2, R<sub>L</sub> = 150  $\Omega$ , C<sub>L</sub> = 4 pF, unless otherwise noted). For G = +2, R<sub>F</sub> = R<sub>G</sub> = 499  $\Omega$  and for G = +1, R<sub>F</sub> = 550  $\Omega$ .

**Table 2.** 



### <span id="page-4-0"></span>ABSOLUTE MAXIMUM RATINGS

#### **Table 3.**



Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### **THERMAL RESISTANCE**

 $\theta_{IA}$  is specified for the worst-case conditions, that is,  $\theta_{IA}$  is specified for device soldered in circuit board for surface-mount packages.

**Table 4. Thermal Resistance** 



#### **Maximum Power Dissipation**

<span id="page-4-1"></span>The maximum safe power dissipation for the ADA4860-1 is limited by the associated rise in junction temperature  $(T_J)$  on the die. At approximately 150°C, which is the glass transition temperature, the plastic changes its properties. Even temporarily exceeding this temperature limit can change the stresses that the package exerts on the die, permanently shifting the parametric performance of the amplifiers. Exceeding a junction temperature of 150°C for an extended period can result in changes in silicon devices, potentially causing degradation or loss of functionality.

The power dissipated in the package  $(P_D)$  for a sine wave and a resistor load is the total power consumed from the supply minus the load power.

 $P_D$  = Total Power Consumed – Load Power

$$
P_D = \Big(\!V_{\textit{supply voltage}} \times I_{\textit{supply current}}\big) \!-\! \frac{V_{\textit{out}}^2}{R_L}
$$

RMS output voltages should be considered.

Airflow across the ADA4860-1 helps remove heat from the package, effectively reducing  $\theta_{JA}$ . In addition, more metal directly in contact with the package leads and through holes under the device reduces  $\theta_{IA}$ .

[Figure 3](#page-4-1) shows the maximum safe power dissipation in the package vs. the ambient temperature for the 6-lead SOT-23 (170°C/W) on a JEDEC standard 4-layer board.  $\theta_{IA}$  values are approximations.



Figure 3. Maximum Power Dissipation vs. Temperature for a 4-Layer Board

### **ESD CAUTION**

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



## <span id="page-5-0"></span>TYPICAL PERFORMANCE CHARACTERISTICS

 $R_{L}$  = 150  $\Omega$  and  $C_{L}$  = 4 pF, unless otherwise noted.



Figure 4. Small Signal Frequency Response for Various Gains



Figure 5. Large Signal Frequency Response for Various Gains



Figure 6. Large Signal 0.1 dB Flatness



Figure 7. Small Signal Frequency Response for Various Gains



Figure 8. Large Signal Frequency Response for Various Gains



Figure 9. Large Signal Frequency Response for Various Output Levels



Figure 10. Small Signal Frequency Response vs. RF

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Figure 11. Small Signal Frequency Response for Various Gains



Figure 12. Large Signal Frequency Response for Various Gains



Figure 13. Large Signal Frequency Response vs. RF



Figure 14. Small Signal Frequency Response for Various Gains



Figure 15. Large Signal Frequency Response for Various Gains



Figure 16. Harmonic Distortion vs. Frequency



Figure 17. Harmonic Distortion vs. Frequency



Figure 18. Harmonic Distortion vs. Frequency for Various Supplies



Figure 19. Harmonic Distortion vs. Frequency



Figure 20. Harmonic Distortion vs. Frequency



Figure 21. Harmonic Distortion vs. Frequency for Various Supplies



Figure 22. Small Signal Transient Response for Various Supplies



<span id="page-8-2"></span><span id="page-8-0"></span>Figure 23. Small Signal Transient Response for Various Capacitor Loads



<span id="page-8-1"></span>Figure 24. Small Signal Transient Response for Various Capacitor Loads



Figure 25. Small Signal Transient Response for Various Supplies



Figure 26. Small Signal Transient Response for Various Capacitor Loads



Figure 27. Small Signal Transient Response for Various Capacitor Loads



Figure 28. Large Signal Transient Response for Various Supplies



<span id="page-9-2"></span><span id="page-9-0"></span>Figure 29. Large Signal Transient Response for Various Capacitor Loads



<span id="page-9-1"></span>Figure 30. Large Signal Transient Response for Various Capacitor Loads



Figure 31. Large Signal Transient Response for Various Supplies



Figure 32. Large Signal Transient Response for Various Capacitor Loads



Figure 33. Large Signal Transient Response for Various Capacitor Loads



Figure 34. Slew Rate vs. Input Voltage



Figure 35. Slew Rate vs. Input Voltage



Figure 36. Settling Time Rising Edge



Figure 37. Slew Rate vs. Input Voltage



Figure 38. Slew Rate vs. Input Voltage



Figure 39. Settling Time Falling Edge



Figure 40. Input Voltage Noise vs. Frequency







Figure 42. Output Overdrive Recovery



Figure 43. Input Current Noise vs. Frequency







Figure 45. Output Overdrive Recovery



Figure 46. Transimpedance and Phase vs. Frequency  $\blacksquare$  Figure 49. Input V<sub>os</sub> vs. Common-Mode Voltage



Figure 47. Supply Current at Various Supplies vs. Temperature Figure 50. Supply Current vs. Supply Voltage



Figure 48. Inverting Input Bias Current vs. Output Voltage





## <span id="page-13-0"></span>APPLICATION INFORMATION

### **POWER SUPPLY BYPASSING**

Attention must be paid to bypassing the power supply pins of the ADA4860-1. High quality capacitors with low equivalent series resistance (ESR), such as multilayer ceramic capacitors (MLCCs), should be used to minimize supply voltage ripple and power dissipation. Generally, a 10 µF tantalum capacitor located in close proximity to the ADA4860-1 is required to provide good decoupling for lower frequency signals. In addition, a 0.1 µF decoupling multilayer ceramic chip capacitor (MLCC) should be located as close to each of the power supply pins as is physically possible, no more than ⅛ inch away. The ground returns should terminate immediately into the ground plane. Locating the bypass capacitor return close to the load return minimizes ground loops and improves performance.

### **FEEDBACK RESISTOR SELECTION**

<span id="page-13-2"></span>The feedback resistor has a direct impact on the closed-loop bandwidth and stability of the current feedback op amp circuit. Reducing the resistance below the recommended value can make the amplifier response peak and even become unstable. Increasing the size of the feedback resistor reduces the closedloop bandwidth. [Table 5](#page-13-1) provides a convenient reference for quickly determining the feedback and gain set resistor values and bandwidth for common gain configurations.

<span id="page-13-3"></span><span id="page-13-1"></span>

**Table 5. Recommended Values and Frequency Performance<sup>1</sup>**

<sup>1</sup> Conditions: V<sub>S</sub> = ±5 V, T<sub>A</sub> = 25°C, R<sub>L</sub> = 150 Ω.

[Figure 51](#page-13-2) and [Figure 52](#page-13-3) show the typical noninverting and inverting configurations and the recommended bypass capacitor values.



Figure 52. Inverting Gain

### <span id="page-14-0"></span>**DRIVING CAPACITIVE LOADS**

If driving loads with a capacitive component is desired, the best frequency response is obtained by the addition of a small series resistance, as shown in [Figure 53.](#page-14-1) [Figure 54](#page-14-2) shows the optimum value for RSERIES vs. capacitive load. The test was performed with a 50 MHz, 50% duty cycle pulse, with an amplitude of 200 mV p-p. The criteria for RSERIES selection was based on maintaining approximately 1 dB of peaking in small signal frequency response. It is worth noting that the frequency response of the circuit can be dominated by the passive roll-off of RSERIES and CL.

<span id="page-14-1"></span>

<span id="page-14-3"></span><span id="page-14-2"></span>Figure 54. Recommended R<sub>SERIES</sub> vs. Capacitive Load

### **POWER DOWN PIN**

The ADA4860-1 is equipped with a power-down function. The POWER DOWN pin allows the user to reduce the quiescent supply current when the amplifier is not being used. The power-down threshold levels are derived from the voltage applied to the  $-V<sub>S</sub>$  pin. When used in single-supply applications, this is especially useful with conventional logic levels. The amplifier is powered down when the voltage applied to the POWER DOWN pin is greater than  $(-V<sub>S</sub> + 0.5 V)$ . The amplifier is enabled whenever the POWER DOWN pin is left open, or the voltage on the POWER DOWN pin is less than  $(-V<sub>S</sub> + 0.5 V)$ . If the POWER DOWN pin is not used, it should be connected to the negative supply.

#### **VIDEO AMPLIFIER**

With low differential gain and phase errors and wide 0.1 dB flatness, the ADA4860-1 is an ideal solution for consumer and professional video applications. [Figure 55](#page-14-3) shows a typical video driver set for a noninverting gain of +2, where  $R_F = R_G = 499 \Omega$ . The video amplifier input is terminated into a shunt 75  $\Omega$  resistor. At the output, the amplifier has a series 75  $\Omega$  resistor for impedance matching to the video load.



### **SINGLE-SUPPLY OPERATION**

Single-supply operation can present certain challenges for the designer. For a detailed explanation on op amp single-supply operation, see Application Note [AN-581.](http://www.analog.com/UploadedFiles/Application_Notes/42621535592205AN581.pdf)

### <span id="page-15-0"></span>**OPTIMIZING FLATNESS AND BANDWIDTH**

When using the ADA4860-1, a variety of circuit conditions and parasitics can affect peaking, gain flatness, and −3 dB bandwidth. This section discusses how the ADA4860-1 small signal responses can be dramatically altered with basic circuit changes and added stray capacitances, see the [Layout and](#page-16-1)  [Circuit Board Parasitics](#page-16-1) section for more information.

<span id="page-15-3"></span>Particularly with low closed-loop gains, the feedback resistor ( $R_f$ ) effects peaking and gain flatness. However, with gain = +1, −3 dB bandwidth varies slightly, while gain = +2 has a much larger variation. For gain  $= +1$ , [Figure 56](#page-15-1) shows the effect that various feedback resistors have on frequency response. In [Figure 56](#page-15-1), peaking is wide ranging yet −3 dB bandwidths vary by only 6%. In this case, the user must pick what is desired: more peaking or flatter bandwidth. [Figure 57](#page-15-2) shows gain  $= +2$ bandwidth and peaking variations vs.  $R_F$  and  $R_L$ . Bandwidth delta vs. R<sub>L</sub> increase was approximately 17%. As R<sub>F</sub> is reduced from 560  $\Omega$  to 301  $\Omega$ , the −3 dB bandwidth changes 49%, with excessive compromises in peaking, see [Figure 57](#page-15-2). For more gain  $= +2$  bandwidth variations vs. R<sub>F</sub>, see [Figure 10](#page-6-0) and [Figure 13](#page-6-0).



Figure 56. Small Signal Frequency Response vs. RF

<span id="page-15-4"></span><span id="page-15-1"></span>

<span id="page-15-2"></span>Figure 57. Small Signal Frequency Response vs.  $R_F$  vs.  $R_L$ 

The impact of resistor case sizes was observed using the circuit drawn in [Figure 58.](#page-15-3) The types and sizes chosen were 0402 case sized thin film and 1206 thick film. All other measurement conditions were kept constant except for the case size and resistor composition.



In [Figure 59](#page-15-4), a slight −3 dB bandwidth delta of approximately +10% can be seen going from a small-to-large case size. The increase in bandwidth with the larger 1206 case size is caused by an increase in parasitic capacitance across the chip resistor.



Figure 59. Small Signal Frequency Response vs. Resistor Size

### <span id="page-16-1"></span><span id="page-16-0"></span>**LAYOUT AND CIRCUIT BOARD PARASITICS**

Careful attention to printed circuit board (PCB) layout prevents associated board parasitics from becoming problematic and affecting gain flatness and −3 dB bandwidth. In the printed circuit environment, parasitics around the summing junction (inverting input) or output pins can alter pulse and frequency response. Parasitic capacitance can be unintentionally created on a PC board via two parallel metal planes with a small vertical separation (in FR4). To avoid parasitic problems near the summing junction, signal line connections between the feedback and gain resistors should be kept as short as possible to minimize the inductance and stray capacitance. For similar reasons, termination and load resistors should be located as close as possible to the respective inputs. Removing the ground plane on all layers from the area near and under the input and output pins reduces stray capacitance.

To illustrate the affects of parasitic capacitance, a small capacitor of 0.4 pF from the amplifiers summing junction (inverting input) to ground was intentionally added. This was done on two boards with equal and opposite gains of +2 and −2. [Figure 60](#page-16-2) reveals the effects of parasitic capacitance at the summing junction for both noninverting and inverting gain circuits. With gain  $= +2$ , the additional 0.4 pF of added capacitance created an extra 43% −3 dB bandwidth extension, plus some extra peaking. For gain = −2, a 5% increase in −3 dB bandwidth was created with an extra 0.4 pF on summing junction.

<span id="page-16-3"></span>

<span id="page-16-2"></span>Added Summing Junction Capacitance

In a second test, 5.6 pF of capacitance was added directly at the output of the gain  $= +2$  amplifier. [Figure 61](#page-16-3) shows the results. Extra output capacitive loading on the ADA4860-1 also causes bandwidth extensions, as seen in [Figure 61](#page-16-3). The effect on the  $gain = +2$  circuit is more pronounced with lighter resistive loading (1 kΩ). For pulse response behavior with added output capacitances, see [Figure 23](#page-8-0), [Figure 24](#page-8-1), [Figure 26](#page-8-2), [Figure 27,](#page-8-1) [Figure 29](#page-9-0), [Figure 30](#page-9-1), [Figure 32](#page-9-2), and [Figure 33.](#page-9-1)



Figure 61. Small Signal Frequency Response vs. Output Capacitive Load

For more information on high speed board layout, go to: [www.analog.com](http://www.analog.com/) and

[www.analog.com/library/analogDialogue/archives/39-](http://www.analog.com/library/analogDialogue/archives/39-09/layout.html) [09/layout.html.](http://www.analog.com/library/analogDialogue/archives/39-09/layout.html)

## <span id="page-17-0"></span>OUTLINE DIMENSIONS



**COMPLIANT TO JEDEC STANDARDS MO-178-AB**

Figure 62. 6-Lead Plastic Surface-Mount Package [SOT-23] (RJ-6) Dimensions shown in millimeters

### **ORDERING GUIDE**

<span id="page-17-1"></span>

 $1 Z = Pb$ -free part.

## **NOTES**

## **NOTES**

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